Testing an Inkjet Printer for Use in MEMS Fabrication

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Outline



- 1. Introduction to MEMS
- 2. Project Description
- 3. Process and General Workflow
- 4. Data Analysis and Results

Introduction to MEMS

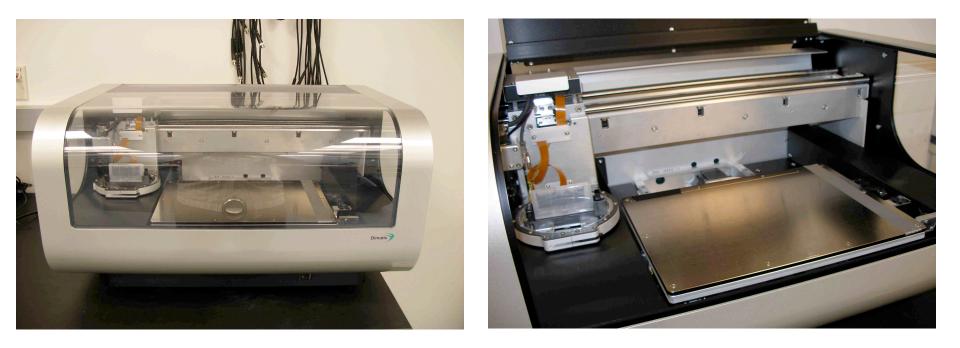
- MEMS are micro-electromechanical-systems
- Various applications include sensors, actuators, and (RF) switches
- Fabricated through surface micromachining processes
 - deposit layers of material on a substrate
 - perform photolithography and etching to remove unwanted material



Project Description



• Use special inkjet printer to deposit thin films of material (layer by layer) on a substrate





- 1. Design MEMS device and chose substrate and ink
- 2. Calibrate printer and print device
- 3. Investigate ideal sintering time and temperature and sinter device in convection oven
- 4. Characterize device using various lab tools

🗑 Image to File Converter*	
File	
Substrate Placement/Tiling Reference Point	
Dimensions Leader Bar XWidth [mm] Width [mm] 69.072 1.000 - Y Height [mm] 1000 - 16.500 - Enable -	
Full Fit Zoom Pan Tiled Preview IV Use Reference Point U:\MEMS\TA0\TA0_4.GBR	
Zoom = 1 / 9.063x Corner = 0.000 , 0.000 Image Size = 5755 x 1374 11.365, -14.268 mm Ref Image = (0,0)	5



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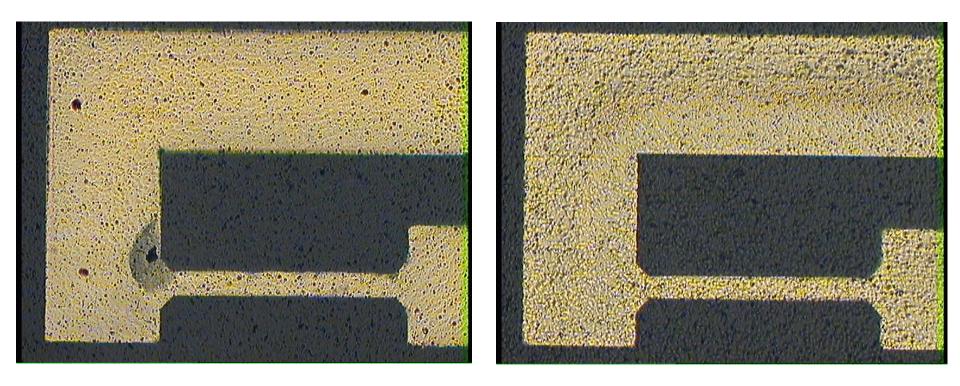


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Substrate Cleaning

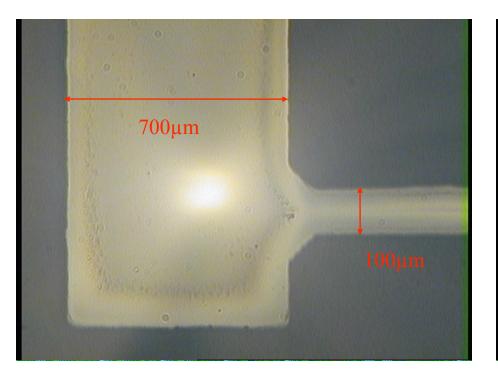


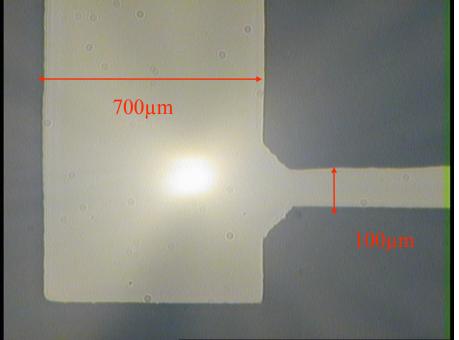
Anemometer design no cleaning

Anemometer design cleaned with alcohol and pre-baked

Resolution Improvements with Cartridge Size



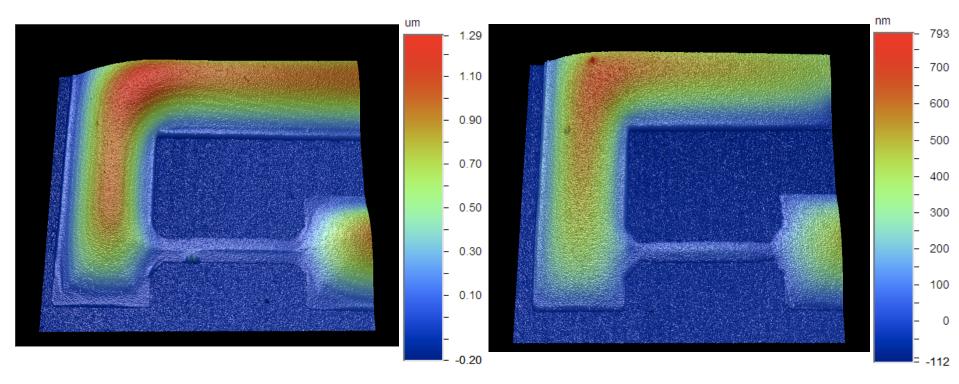




Anemometer design 10pL cartridge Anemometer design *lpL cartridge*

Resolution Improvements with Cartridge Size cont.

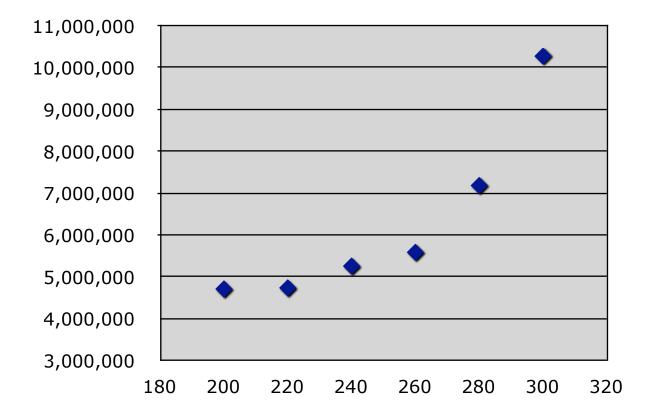




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Conductivity and Sintering Temperature





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Future Work



- Continue testing other substrates and observe relevant topography characteristics and measure conductivity
- Extend printing to include more complex, multi-layered devices



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